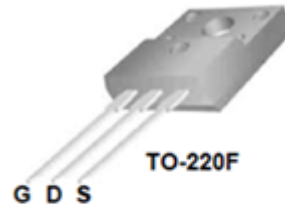


900V N-Channel MOSFET

General Description

This Power MOSFET is produced using advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.



Features

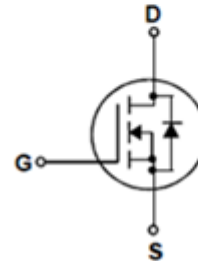
7A, 900V, $R_{DS(on)typ.} = 1.8\Omega @ V_{GS} = 10V$

Low gate charge (48nC)

High ruggedness

Fast switching

Improved dv/dt capability



Absolute Maximum Ratings $T_c = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter		JFFM7N90C	Units
V_{DSS}	Drain – Source Voltage		900	V
I_D	Drain Current	Continuous ($T_c = 25^\circ\text{C}$)	7	A
		Continuous ($T_c = 100^\circ\text{C}$)	4*	A
I_{DM}	Drain Current - Pulsed (Note 1)		28	A
V_{GSS}	Gate – Source Voltage		± 30	V
EAS	Single Pulsed Avalanche Energy (Note 2)		311	mJ
I_{AR}	Avalanche Current (Note 1)		7	A
E_{AR}	Repetitive Avalanche Energy (Note 1)		20	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		5.0	V/ns
P_D	Power Dissipation ($T_c = 25^\circ\text{C}$)		45.5	W
	-Derate above 25°C		0.364	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes 1/8" from case for 5 seconds		300	$^\circ\text{C}$

*Drain current limited by maximum junction temperature.

Thermal characteristics

Symbol	Parameter	JFFM7N90C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.75	$^{\circ}\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	--	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics $T_c = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain – Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	900	--	--	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 uA, Referenced to 25 °C	--	0.65	--	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 900 V, V _{GS} = 0 V	--	--	1	uA
		V _{DS} = 720 V, T _c = 125 °C	--	--	10	uA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{GS} = 0 V	--	--	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{GS} = 0 V	--	--	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 uA	2.0	--	4.0	V
R _{DS(on)}	Static Drain-Source on-Resistance	V _{GS} = 10 V, I _D = 3.5A	--	1.8	1.95	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 7 A (Note 4)	--	11.5	--	S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	--	1420	--	pF
C _{oss}	Output Capacitance		--	120	--	pF
C _{rss}	Reverse Transfer Capacitance		--	9	--	pF
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DS} = 450 V, I _D = 7.0 A , R _G = 25Ω , V _{GS} = 10 V (Note 4,5)	--	19	--	ns
t _r	Turn-On Rise Time		--	15	--	ns
t _{d(off)}	Turn-Off Delay Time		--	46	--	ns
t _f	Turn-Off Fall Time		--	22	--	ns
Q _g	Total Gate Charge	V _{DS} = 450 V, I _D = 7.0 A V _{GS} = 10 V (Note 4,5)	--	48	--	nC
Q _{gs}	Gate-Source Charge		--	12	--	nC
Q _{gd}	Gate-Drain Charge		--	11	--	nC
Drain – Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	7	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	28	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.0 A	--	--	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 7.0 A	--	390	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/us (Note 4)	--	4.1	--	uC

Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature
2. $L = 12\text{ mH}$, $I_{AS} = 7\text{ A}$, $V_{DD} = 50\text{ V}$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}\text{C}$
3. $I_{SD} \leq 7.0\text{ A}$, $di/dt \leq 200\text{ A}/\mu\text{s}$, $V_{DD} \leq BV_{DS}$, Starting $T_J = 25^{\circ}\text{C}$
4. Pulsed Test : Pulsed width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

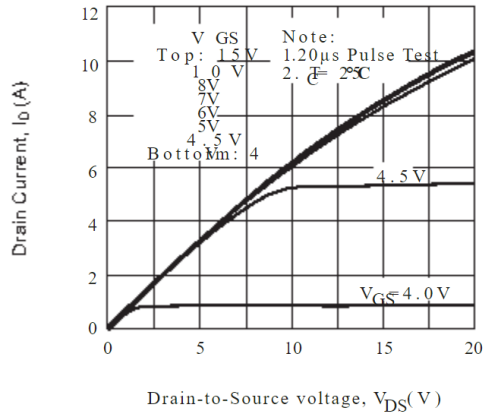


Figure 1. On-Region Characteristics

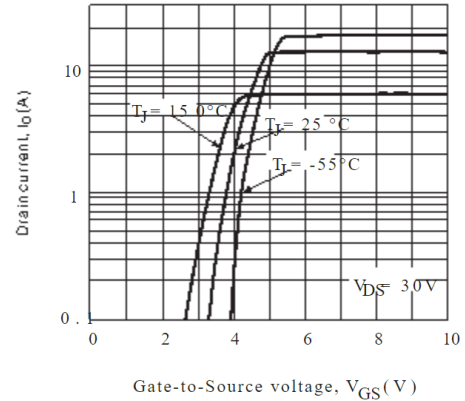


Figure 2. Transfer Characteristics

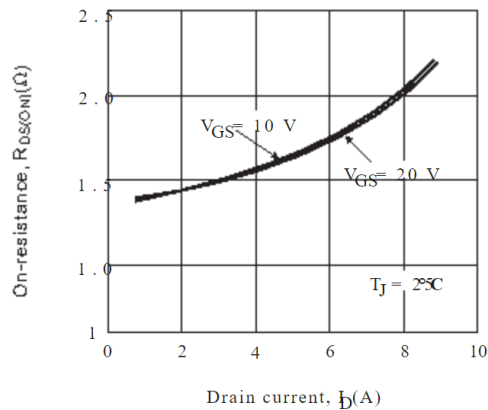


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

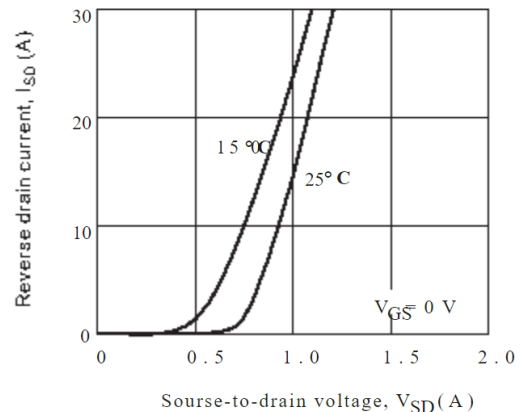


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

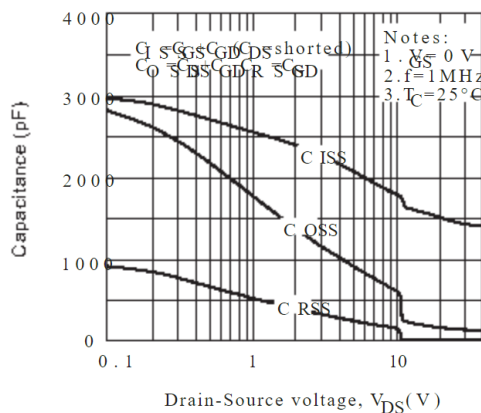


Figure 5. Capacitance Characteristics

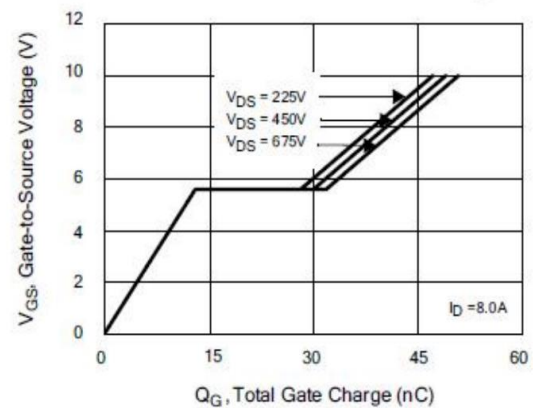
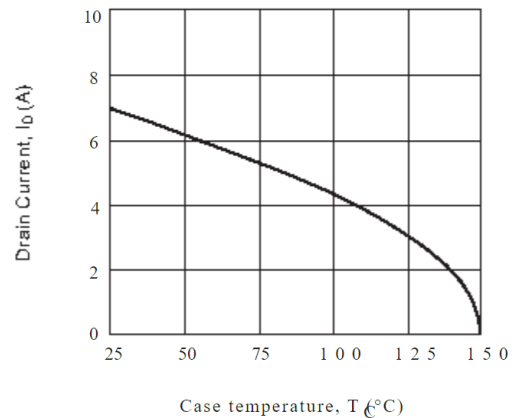
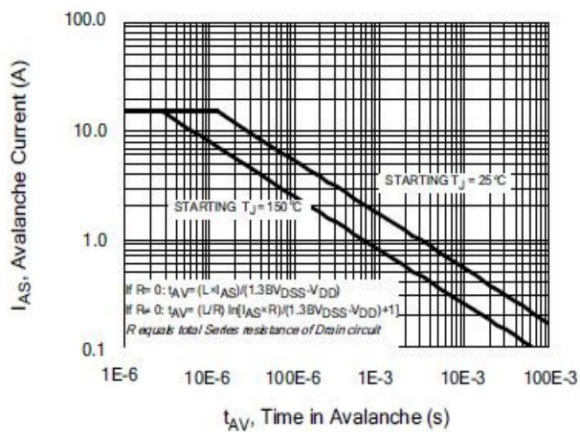
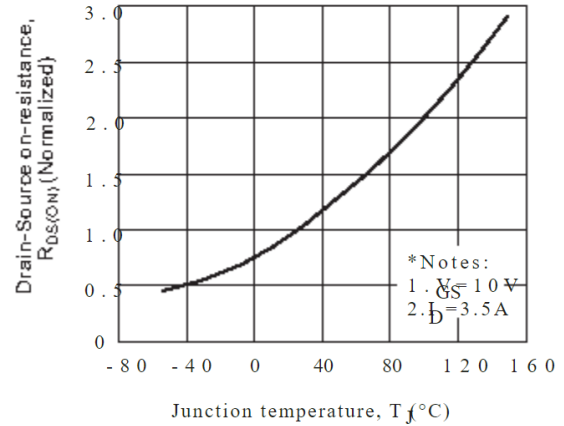
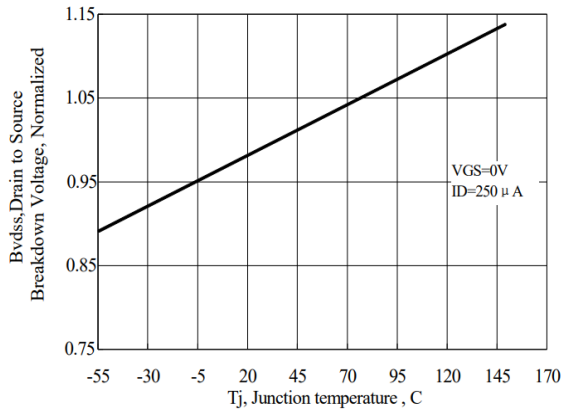


Figure 6. Gate Charge Characteristics

Typical Characteristics



Typical Characteristics

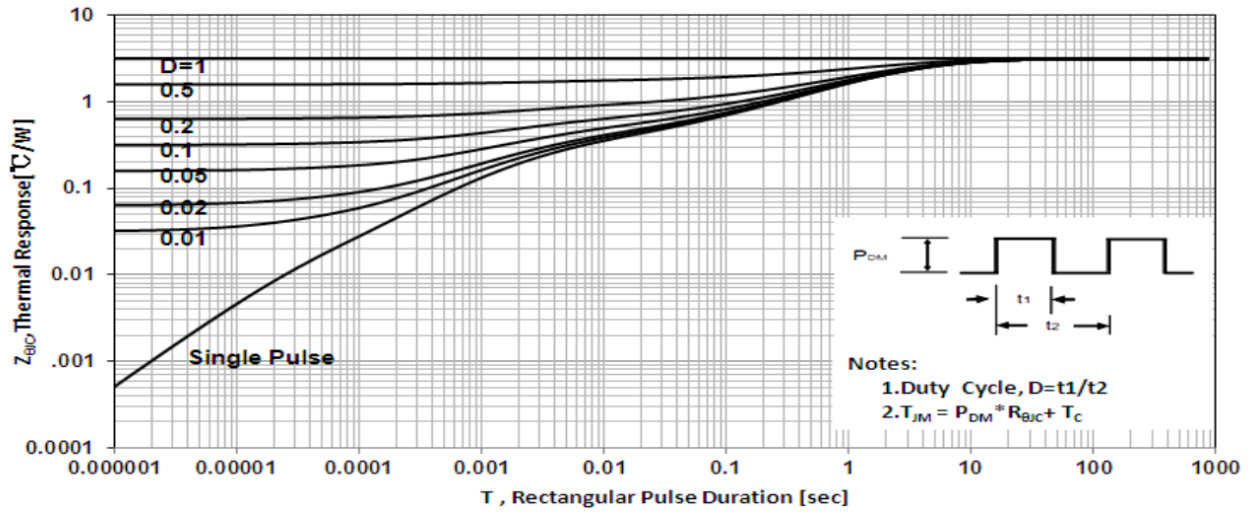
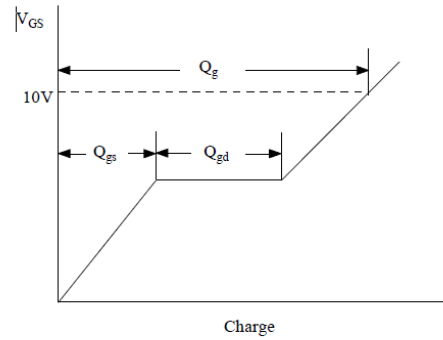
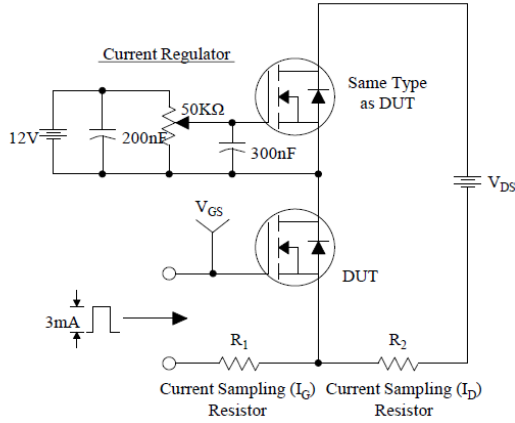
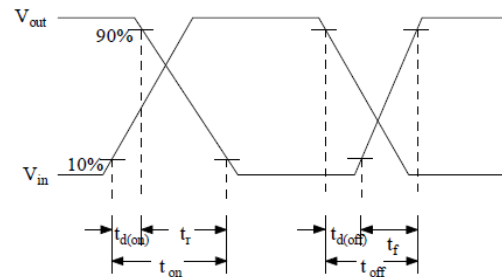
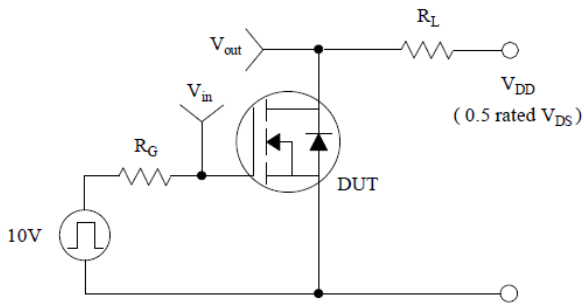


Figure 11. Transient Thermal Response Curve for JFFM7N90C

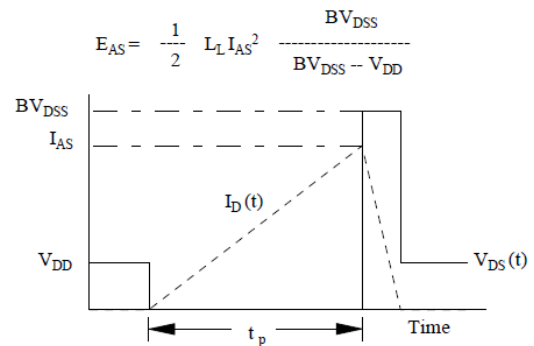
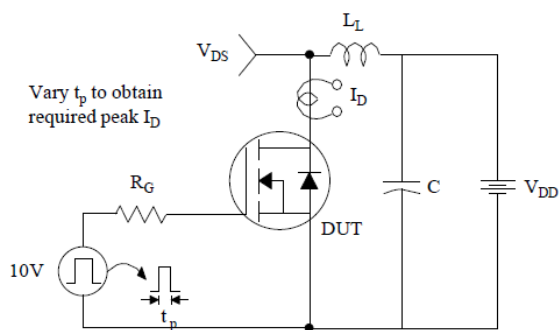
Test Circuit & Waveform



Gate Charge Test Circuit & Waveform

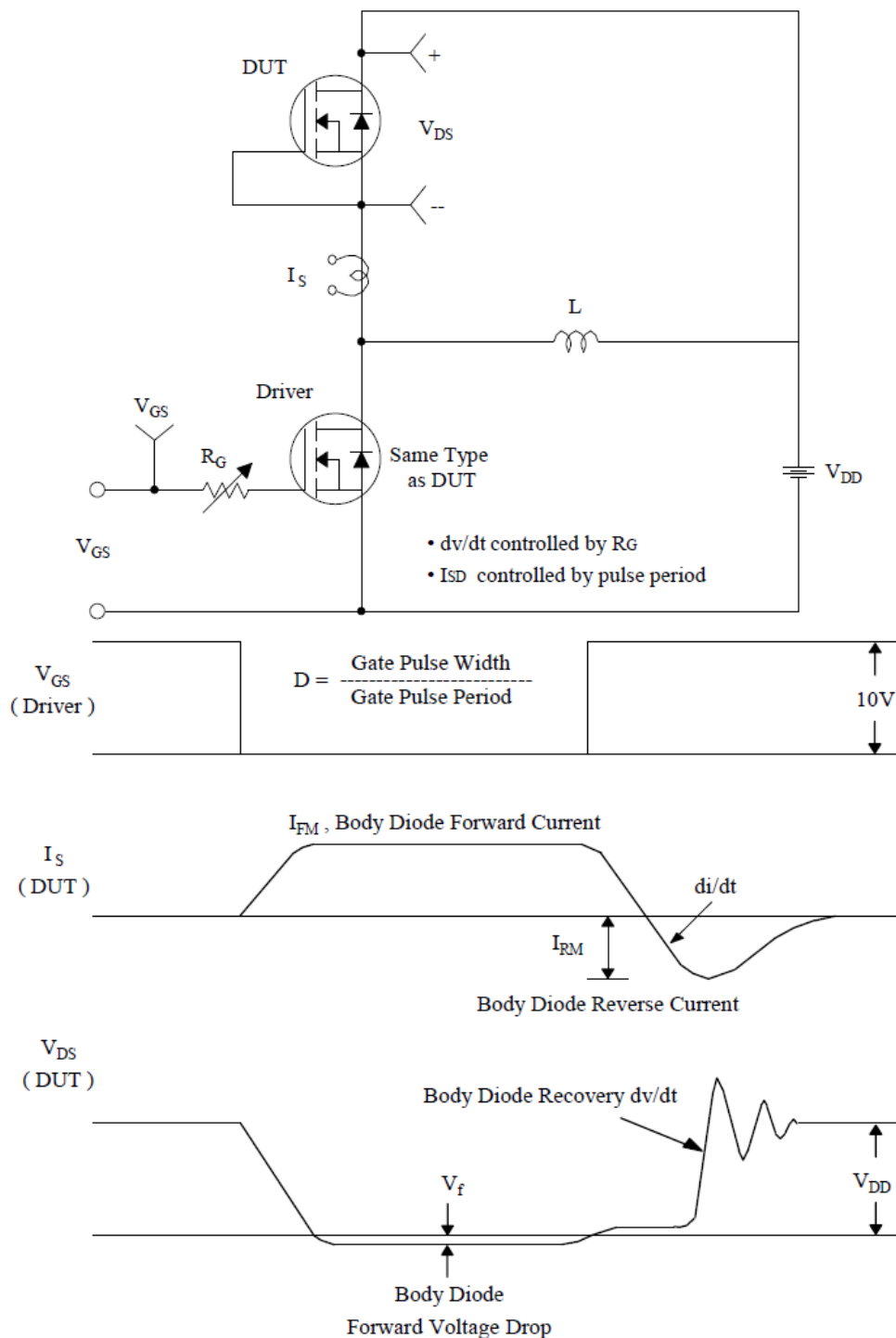


Resistive Switching Test Circuit & Waveforms



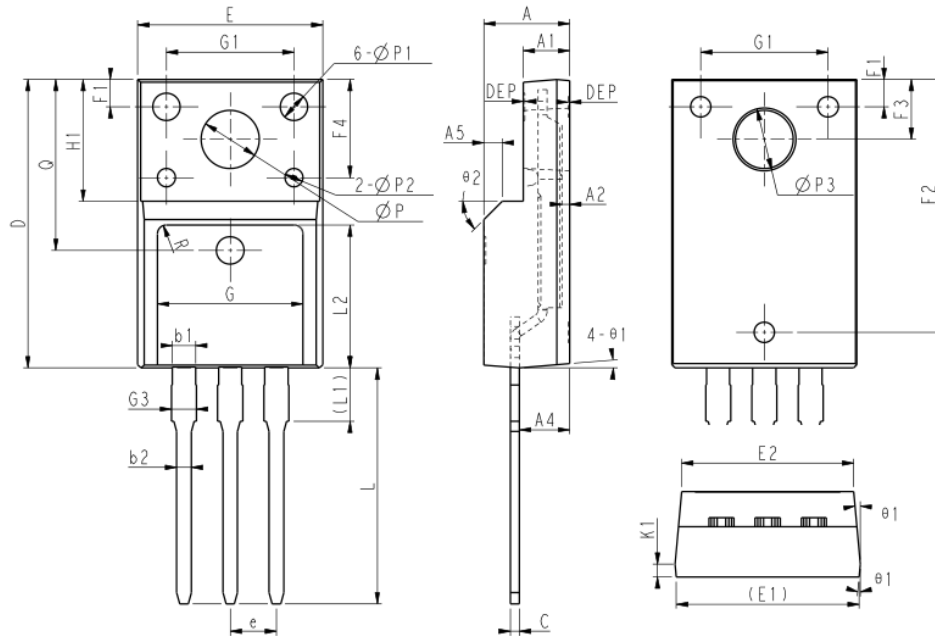
Unclamped Inductive Switching Test Circuit & Waveforms

Test Circuit & Waveform



Peak Diode Recovery dv/dt Test Circuit & Waveforms

Package



COMMON DIMENSIONS

SYMBOL	MIN	NOM	MAX
E	10.00	10.16	10.32
E1	9.94	10.04	10.14
F2	9.36	9.46	9.56
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2	0.43	-	0.48
A4	2.66	2.76	2.86
A5	-	1.00REF	-
c	0.45	0.50	0.60
D	15.67	15.87	16.07
Q	-	9.40REF	-
H1	-	6.70REF	-
e	-	2.54BSC	-
ΦP	-	3.18REF	-
L	12.78	12.98	13.18
L1	2.83	2.93	3.03
L2	7.70	7.80	7.90
ΦP1	1.40	1.50	1.60
ΦP2	0.95	1.00	1.05
ΦP3	-	3.45REF	-
θ1	3°	5°	7°
θ2	-	45°	-
DEP	0.05	0.10	0.15
F1	1.00	1.50	2.00
F2	13.80	13.90	14.00
F3	3.20	3.30	3.40
F4	5.30	5.40	5.50
G	7.80	8.00	8.20
G1	6.90	7.00	7.10
G3	1.25	1.35	1.45
b1	1.23	1.28	1.38
b2	0.75	0.80	0.90
K1	0.65	0.70	0.75
R	-	0.50REF	-

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